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Supporting Information

for

FeV₃O₈/MoS₂ nanostructure heterojunctions as a highly effective

electrocatalyst for hydrogen evolution

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Fig. S1. (a) FESEM image of pure FeV_3O_8 nanorods, (b) Low and (c) high magnification FESEM images of GNs-MoS₂ and (d) Particle size distribution of pure MoS_2 .



Fig. S2. (a) UV–Vis spectra of pure MoS_2 and FVO_{40} -MS, (b) EPR spectra for S vacancies of MoS_2 and FVO_{40} -MS at room-temperature.

UV-Vis and EPR analysis of the samples

UV-Vis absorption spectra and electron paramagnetic resonance (EPR) analysis were performed to gain more information for the active defects of FVO/MS heterostructure. In the UV-Vis absorption spectra (Fig. S2a), the FVO₄₀-MS shows broaden absorption peaks in the range from 400 to 800 nm compared with MS. Obviously, the absorption capacity of visible light is significantly enhanced in FVO₄₀-MS, which could be ascribed to the increased defects in FVO/MS heterojunction structure.^{1, 2} Then, the room-temperature EPR was performed to further investigate the existence and the type of defects. In Fig. S2b, the FVO₄₀-MS and MS show distinct EPR signals, giving the g-value of 2.003, which could be indexed as the surface S vacancies (V_S).³ Notably, the EPR intensity of FVO₄₀-MS is much stronger than that of pure MS, indicating that the introduction of FVO into MS brings more defects of V_S in FVO/MS heterojunction structure.^{3, 4} The greatly enhanced V_S in the FVO/MS heterostructure leads to the decreasing of spontaneous non-radiative recombination from the trap states,⁵⁻⁷ which resulted the enhancement of the fluorescence intensity. References:

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Fig. S3. LSV curve of FVO/MS mechanical mixing up in the same proportion of FVO_{40} - MS served as a contrast to pure MS.



Fig. S4. The Cyclic voltammetry curves of (a) MS; (b) FVO_{10} -MS; (c) FVO_{20} -MS and (d) FVO_{50} -MS at various scan rates (20-140 mV/s) in the region of -0.1~ -0.2 V.



Fig. S5. (a) Transient photocurrent responses of the as-prepared samples under visible light; (b) Nitrogen adsorption–desorption isotherms of pure MoS_2 and FVO_{40} -MS.



Fig. S6. Nitrogen adsorption–desorption isotherms and the corresponding pore size distribution curves of (a) FVO, (b) MS, (c) FVO_{10} -MS, (d) FVO_{20} -MS, (e) FVO_{40} -MS and (f) FVO_{50} -MS.

UV-Vis DRS and UPS analysis of the as-prepared samples

To further estimate the band gap structure of MS, FVO and FVO₄₀-MS, the UV– Vis diffuse reflectance spectrum (UV-Vis DRS) and ultraviolet photoelectron spectroscopy (UPS) analysis were carried out (Fig. S8). The band gap energy was determined based on the UV-Vis DRS absorption spectrum curve and calculated according to equation 1 (see ref.7) : $\alpha hv = A (hv - E_g)^{n/2}$, in which α , v, A, and Eg are the absorption coefficient, light frequency, proportionality constant, and band gap, respectively. The value of n depends on the characteristic of optical transition of the material. For FeV₃O₈ (direct semiconductor), n is 1 (see ref.9); while for MoS₂ (indirect semiconductor), n=4 (see ref.10). Bandgap curves of FeV₃O₈ and MoS₂ were collected using the Tauc plot based on the UV-Vis DRS data (Fig. S7a-7c). The value of the intersection of the tangent line with the horizontal axis represents the bandgap energy. The Eg of FeV₃O₈ and MoS₂ were 2.4 eV and 2.0 eV, respectively.

The work function (W_f) obtained from UPS study are used to investigate the behaviors of charge separation and transfer along the FVO/MS heterojunction. The calculation of W_f is based on the following equation: $W_f = hv-E_{onset}$ (see ref.11), where W_f was determined by subtracting the secondary cut off edge value (E_{onset}) with linear extrapolation towards the background from the He-I excitation light source (hv, 21.2 eV). From the UPS results (Fig. S7d-7f), the W_f of the FVO, MS and FVO₄₀-MS are 5.5 eV, 5.3 eV and 5.6 eV. Thus the valence band (VB) for FeV_3O_8 and MoS_2 are calculated to 2.2 eV and 1.9 eV, respectively. Wf was defined as the energy required to remove an electron at the E_f deep-seated inside the material and place it at infinity ($E_{VAC}=0$), which is based on the formula: $E_f = E_{VAC}-W_f$ (see ref.11). Thus, the value of E_f for FVO, MS and FVO₄₀-MS are -5.5 eV, -5.3 eV and -5.6 eV, respectively. Then, the conduction bands (CB) of FeV₃O₈ and MoS₂ are calculated via equation 2 (see ref.7): $E_{CB}=E_{VB}-E_{g}$, and the corresponding E_{CB} values are -0.2 eV and -0.1 eV, respectively. The detailed parameters of band structure for pure FeV_3O_8 and MoS_2 are shown in Fig. S8a. When FeV₃O₈/MoS₂ heterostructure was formed, there will be a shift of Femi levels in the semiconductor interface owing to the different W_f (see ref.8). In general, electrons transfer from a higher Fermi level to a lower one. According to the results of UPS measurement, the W_f of pure FeV₃O₈ (5.5 eV) is higher than that of MoS_2 (5.3 eV). Therefore, the band bending of MoS_2 is upward, while the band bending of FeV_3O_8 is downward (see Fig. S8b and ref.13). Based on the relative energy band structure of FeV_3O_8 and MoS_2 , the charge transfer route of FVO/MS belongs to Type-I heterojunction (see ref.14 and ref.15). The electrons in VB of FeV_3O_8 are excited to the CB under light illumination. Then, the photogenerated electrons will immediately shift to the CB of MoS_2 . As lots of photo-induced electrons rapidly migrate to the active sites at the edge of MoS_2 nanosheet and participate the hydrogen evolution reaction, the HER activity of the MoS_2 was significantly enhanced.

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Fig. S7. (a) UV–Vis DRS spectra of MoS_2 and FeV_3O_8 , Tauc plot of (b) MoS_2 and (c) FeV_3O_8 , (d-f) UPS spectra and corresponding E_{CB} curves (inset) of FVO, MS and FVO_{40} -MS.



Fig. S8. (a)The band structures of FVO and MS, (b) Mechanism graph of electronic transfer in FVO/MS heterostructure.



Fig. S9. (a) FESEM image and (b) XRD pattern of FVO₄₀-MS after HER tests.